

# **RJP6831PJWS**

750V - 300A - IGBT Applications: Automotive R07DS1577EJ0100 Rev.1.00 Nov.22nd.2024

Datasheet

## Features

- 750 V Trench & field stop high AE4 technology
- Low collector to emitter saturation voltage

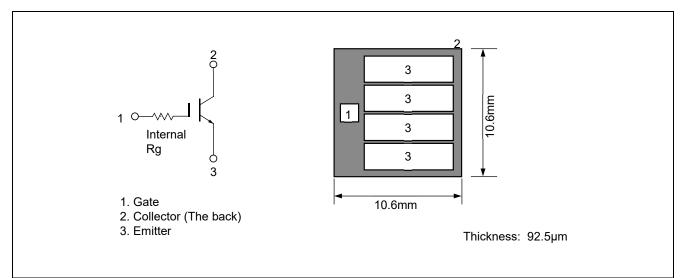
 $V_{CE(sat)}$  = 1.4 V typ. (at I<sub>C</sub> = 300 A, V<sub>GE</sub> = 15 V, Tj = 25 °C)

- Low Switching loss
- Easy paralleling by internal Rg
- AEC Q101 (HTRB, HTGB) qualified
- Applications: Hybrid and electric vehicle inverter

#### Key performance

| Product name | Vces  | lc    | Die size              | Package    |
|--------------|-------|-------|-----------------------|------------|
| RJP6831PJWS  | 750 V | 300 A | 112.4 mm <sup>2</sup> | Sawn wafer |
|              |       |       | (10.6 mm x 10.6 mm)   |            |

## Outline





#### **Mechanical Parameters**

| Parameter                        | value   |  |  |
|----------------------------------|---|--|--|
| Die size                         | 112.4 mm <sup>2</sup> (10.6 mm x 10.6 mm)                   |  |  |
| Emitter pad size                 | See Die Dimension   |  |  |
| Gate pad size                    | 1.5 mm x 1.5 mm   |  |  |
| Die thickness                    | 92.5 μm   |  |  |
| Wafer size                       | 200 mm  |  |  |
| Passivation front side           | Polyimide   |  |  |
| Pad metallization                | Ni / Au – 2.5 μm / 0.035 μm                                 |  |  |
| Backside metallization           | Ni / Au - 0.6 μm / 0.1 μm                                   |  |  |
| Die attach recommendation Solder |   |  |  |
| Wire bond recommendation         | Al wire $\leq$ 500 $\mu$ m                                  |  |  |
| Recommended storage environment  | Stored in original container, in dry air or nitrogen.       |  |  |
|                                  | 15 months after packing, at an ambient temperature of 20 to |  |  |
|                                  | 30 °C, dew-point under -30 °C                               |  |  |

# **Absolute Maximum Ratings**

|                              |             |           | (Tj = 25 °C unless | otherwise noted) |  |
|------------------------------|-------------|-----------|--------------------|------------------|--|
| Item                         |             | Symbol    | Ratings            | Unit             |  |
| Collector to emitter voltage | Tj = −40 °C | VCES      | 650 Notes1         | V                |  |
|                              | Tj = 25 °C  |           | 750                | V                |  |
|                              | Tj = 175 °C |           | 750 Notes1         | V                |  |
| Gate to emitter voltage      |             | VGES      | ±30                | V                |  |
| Collector current            |             | IC(DC)    | _ Notes2           | A                |  |
| Pulse collector current      |             | IC(pulse) | 900 Notes1, 4      | A                |  |
| Junction temperature         |             | Tj        | 175 Notes3         | °C               |  |

Notes: 1. Not subject to product test - verified by design/characterization.

2. Depending on thermal properties of assembly, Tj  $\leq$  175 °C.

3. AEC-Q101 complaint. HTGB and HTRB are carried out to determine.

4. PW = 10 μs, Duty < 1 %

5. Continuous heavy condition (e.g. high temperature/voltage/current or high variation of temperature) may affect reliability even if it is within the absolute maximum ratings. Please consider derating condition for appropriate reliability in reference Renesas Semiconductor Reliability Handbook (Recommendation for Handling and Usage of Semiconductor Devices) and individual reliability data.

# **Electrical Characteristics 1**

(Tested on wafer, Ta = 25 °C unless otherwise noted)

| Item                                   | Symbol   | Test Conditions                                 | Min  | Тур  | Max  | Unit |
|--|----------|---|------|------|------|------|
| Collector to emitter breakdown voltage | V(BR)CES | I <sub>C</sub> = 100 μA, V <sub>GE</sub> = 0 V  | 750  | —    | _    | V    |
| Gate to emitter threshold voltage      | VGE(th)  | V <sub>CE</sub> = 10 V, I <sub>C</sub> = 300 mA | 5.5  | 6.5  | 7.5  | V    |
| Collector to emitter leakage current   | ICES     | Vce = 750 V, Vge = 0 V                          | _    |      | 10   | μA   |
| Gate to emitter leakage current        | IGES     | V <sub>GE</sub> = ±30 V, V <sub>CE</sub> = 0 V  | _    |      | ±600 | nA   |
| Internal gate resistor                 | Rg       | —   | 2.64 | 3.30 | 3.96 | Ω    |

Notes: 6. The characteristic items specified in this table guarantee the electrical characteristics in the wafer state but do not the characteristic fluctuations or characteristic defects that occur in the processes after assembling.

### **Electrical Characteristics 2**

| (                                       |          |  | , <u> </u> |       |     |      |
|---|----------|--|------------|-------|-----|------|
| Item                                    | Symbol   | Test Conditions  | Min        | Тур   | Мах | Unit |
| Collector to emitter breakdown voltage  | V(BR)CES | $I_{C} = 100 \ \mu\text{A}, \ V_{GE} = 0 \ V$ $T_{j} = -40 \ ^{\circ}C \ ^{Notes7}$    | 650        |       | _   | V    |
|   |          | $I_{C} = 5 \text{ mA}, V_{GE} = 0 \text{ V}$ $T_{j} = 175 \text{ °C} ^{\text{Notes7}}$ | 750        |       | _   | V    |
| Collector to emitter saturation voltage | VCE(sat) | I <sub>C</sub> = 300 A V <sub>GE</sub> = 15 V<br><sub>Notes7</sub>                     | _          | 1.4   | 1.7 | V    |
| Input capacitance                       | Cies     | V <sub>CE</sub> = 25 V, V <sub>GE</sub> = 0 V  | —          | 10800 | _   | pF   |
| Output capacitance                      | Coes     | f = 1 MHz  | —          | 650   | _   | pF   |
| Reverse transfer capacitance            | Cres     | Notes7   | —          | 220   |     | pF   |

(Not subject to production test, designed target value, Tj = 25 °C unless otherwise noted)

Notes: 7. Designed target value on Renesas measurement condition.

# **Electrical Characteristics 3**

| (Not subject to production test, designed target value, Tj = 25 °C unless otherwise note | ed) |
|--|-----|
|--|-----|

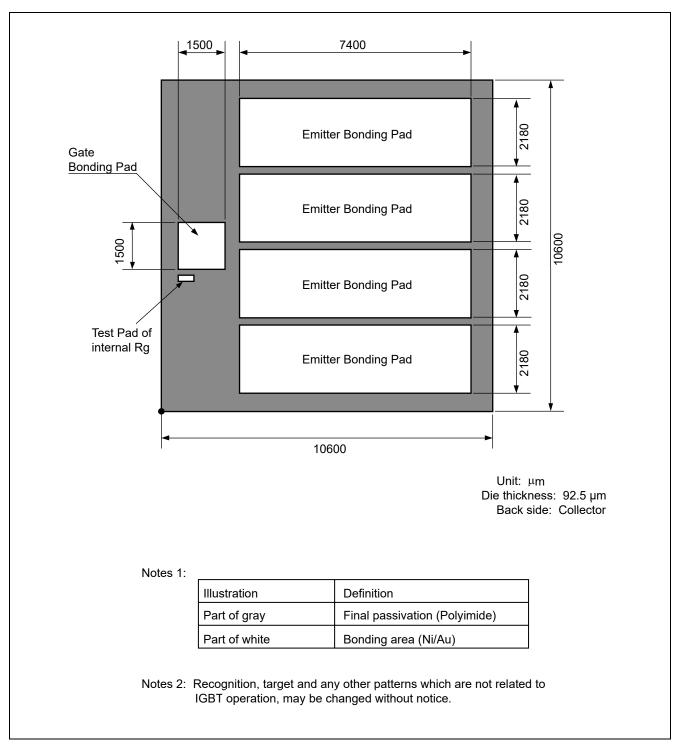
| Item                              | Symbol | Test Conditions  | Min | Тур | Max | Unit |
|-----------------------------------|--------|--|-----|-----|-----|------|
| Rise time                         | tr     | V <sub>CC</sub> = 475 V, I <sub>C</sub> = 300 A<br>V <sub>GE</sub> = 15 V, R <sub>in</sub> = 5.6 Ω |     | 44  |     | ns   |
| Fall time                         | tf     | Inductive load Notes8, 9   |     | 122 |     | ns   |
| Short circuit capability          | tsc    | V <sub>CC</sub> = 360 V, V <sub>GE</sub> = 15 V<br>Tj = 150 °C <sup>Notes8, 9</sup>                | 6.0 |     |     | μs   |
| Short circuit capability (Energy) | Esc    | V <sub>CC</sub> = 500 V, V <sub>GE</sub> = 18 V<br>Tj = 175 °C <sup>Notes8, 9</sup>                | 2.5 |     |     | J    |

Notes: 8. Designed target value on Renesas measurement condition.

9. This value is influenced by parasitic inductance and assembly condition.



#### **Die Dimension**



# **Ordering Information**

Please contact your Renesas sales representative for sample requests.

| Delivery Form      | Ordering Part Number | Remark |
|--------------------|----------------------|--------|
| Sawn wafer on foil | RJP6831PJWS-00#W0    |        |

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